



**THE DATASHEET OF  
CY7C1034DV33-10BGXI**



## 6-Mbit (256K X 24) Static RAM

### Features

- High speed
  - $t_{AA} = 10 \text{ ns}$
- Low active power
  - $I_{CC} = 175 \text{ mA}$  at  $f = 100 \text{ MHz}$
- Low CMOS standby power
  - $I_{SB2} = 25 \text{ mA}$
- Operating voltages of  $3.3 \pm 0.3 \text{ V}$
- 2.0 V data retention
- Automatic power-down when deselected
- Transistor-transistor logic (TTL) compatible inputs and outputs
- Easy memory expansion with  $\overline{CE}_1$ ,  $CE_2$ , and  $\overline{CE}_3$  features
- Available in Pb-free standard 119-Ball PBGA

### Functional Description

The CY7C1034DV33 is a high performance CMOS static RAM organized as 256K words by 24 bits. This device has an automatic power-down feature that significantly reduces power consumption when deselected.

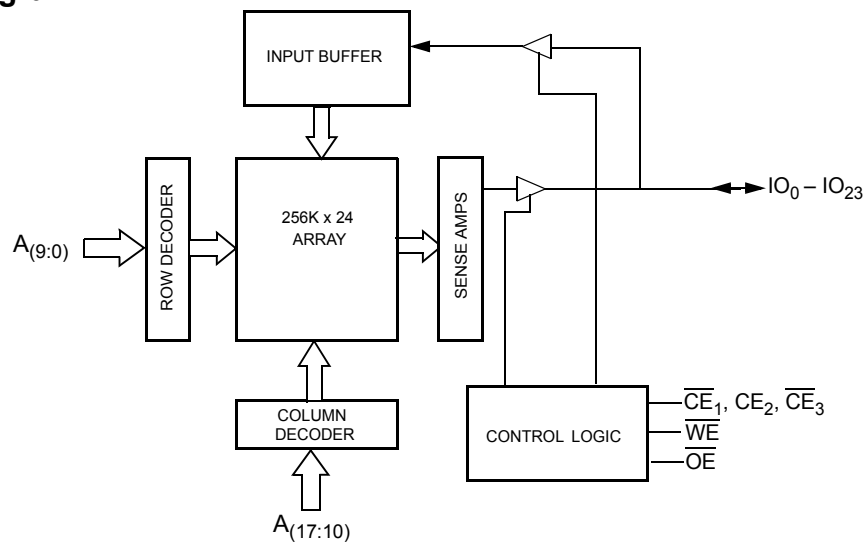
To write to the device, enable the chip ( $\overline{CE}_1$  LOW,  $CE_2$  HIGH, and  $\overline{CE}_3$  LOW) while forcing the Write Enable ( $\overline{WE}$ ) input LOW.

To read from the device, enable the chip by taking  $\overline{CE}_1$  LOW,  $CE_2$  HIGH, and  $\overline{CE}_3$  LOW, while forcing the Output Enable ( $\overline{OE}$ ) LOW and the Write Enable ( $\overline{WE}$ ) HIGH. See the [Truth Table on page 7](#) for a complete description of Read and Write modes.

The 24 IO pins ( $IO_0$  to  $IO_{23}$ ) are placed in a high impedance state when the device is deselected ( $\overline{CE}_1$  HIGH,  $CE_2$  LOW, or  $\overline{CE}_3$  HIGH) or when the output enable ( $\overline{OE}$ ) is HIGH during a write operation. ( $CE_1$  LOW,  $CE_2$  HIGH,  $CE_3$  LOW, and  $\overline{WE}$  LOW).

For a complete list of related documentation, [click here](#).

### Logic Block Diagram



**Selection Guide**

Description	-10	Unit
Maximum access time	10	ns
Maximum operating current	175	mA
Maximum CMOS standby current	25	mA

**Pin Configuration**

Figure 1. 119-Ball PBGA Top View <sup>[1]</sup>

	1	2	3	4	5	6	7
<b>A</b>	NC	A	A	A	A	A	NC
<b>B</b>	NC	A	A	$\overline{CE}_1$	A	A	NC
<b>C</b>	IO <sub>12</sub>	NC	CE <sub>2</sub>	A	$\overline{CE}_3$	NC	IO <sub>0</sub>
<b>D</b>	IO <sub>13</sub>	V <sub>DD</sub>	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>DD</sub>	IO <sub>1</sub>
<b>E</b>	IO <sub>14</sub>	V <sub>SS</sub>	V <sub>DD</sub>	V <sub>SS</sub>	V <sub>DD</sub>	V <sub>SS</sub>	IO <sub>2</sub>
<b>F</b>	IO <sub>15</sub>	V <sub>DD</sub>	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>DD</sub>	IO <sub>3</sub>
<b>G</b>	IO <sub>16</sub>	V <sub>SS</sub>	V <sub>DD</sub>	V <sub>SS</sub>	V <sub>DD</sub>	V <sub>SS</sub>	IO <sub>4</sub>
<b>H</b>	IO <sub>17</sub>	V <sub>DD</sub>	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>DD</sub>	IO <sub>5</sub>
<b>J</b>	NC	V <sub>SS</sub>	V <sub>DD</sub>	V <sub>SS</sub>	V <sub>DD</sub>	V <sub>SS</sub>	NC
<b>K</b>	IO <sub>18</sub>	V <sub>DD</sub>	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>DD</sub>	IO <sub>6</sub>
<b>L</b>	IO <sub>19</sub>	V <sub>SS</sub>	V <sub>DD</sub>	V <sub>SS</sub>	V <sub>DD</sub>	V <sub>SS</sub>	IO <sub>7</sub>
<b>M</b>	IO <sub>20</sub>	V <sub>DD</sub>	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>DD</sub>	IO <sub>8</sub>
<b>N</b>	IO <sub>21</sub>	V <sub>SS</sub>	V <sub>DD</sub>	V <sub>SS</sub>	V <sub>DD</sub>	V <sub>SS</sub>	IO <sub>9</sub>
<b>P</b>	IO <sub>22</sub>	V <sub>DD</sub>	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>SS</sub>	V <sub>DD</sub>	IO <sub>10</sub>
<b>R</b>	IO <sub>23</sub>	NC	NC	NC	NC	NC	IO <sub>11</sub>
<b>T</b>	NC	A	A	$\overline{WE}$	A	A	NC
<b>U</b>	NC	A	A	$\overline{OE}$	A	A	NC

**Note**

1. NC pins are not connected on the die.

## Maximum Ratings

Exceeding maximum ratings may impair the useful life of the device. These user guidelines are not tested.

Storage Temperature .....	-65 °C to +150 °C
Ambient Temperature with Power Applied .....	-55 °C to +125 °C
Supply Voltage on V <sub>CC</sub> Relative to GND [2] .....	-0.5 V to +4.6 V
DC Voltage Applied to Outputs in High Z State [2] .....	-0.5 V to V <sub>CC</sub> + 0.5 V

DC Input Voltage [2] .....	-0.5 V to V <sub>CC</sub> + 0.5 V
Current into Outputs (LOW) .....	20 mA
Static Discharge Voltage .....	>2001 V (MIL-STD-883, Method 3015)
Latch up Current .....	>200 mA

## Operating Range

Range	Ambient Temperature	V <sub>CC</sub>
Industrial	-40 °C to +85 °C	3.3 V ± 0.3 V

## DC Electrical Characteristics

Over the operating range

Parameter	Description	Test Conditions [3]	-10		Unit
			Min	Max	
V <sub>OH</sub>	Output HIGH voltage	Min V <sub>CC</sub> , I <sub>OH</sub> = -4.0 mA	2.4		V
V <sub>OL</sub>	Output LOW voltage	Min V <sub>CC</sub> , I <sub>OL</sub> = 8.0 mA		0.4	V
V <sub>IH</sub>	Input HIGH voltage		2.0	V <sub>CC</sub> + 0.3	V
V <sub>IL</sub> [2]	Input LOW voltage		-0.3	0.8	V
I <sub>IX</sub>	Input leakage current	GND ≤ V <sub>IN</sub> ≤ V <sub>CC</sub>	-1	+1	μA
I <sub>OZ</sub>	Output leakage current	GND ≤ V <sub>OUT</sub> ≤ V <sub>CC</sub> , output disabled	-1	+1	μA
I <sub>CC</sub>	V <sub>CC</sub> operating supply current	Max V <sub>CC</sub> , f = f <sub>MAX</sub> = 1/t <sub>RC</sub> , I <sub>OUT</sub> = 0 mA CMOS levels		175	mA
I <sub>SB1</sub>	Automatic CE power-down current — TTL inputs	Max V <sub>CC</sub> , CE <sub>1</sub> , CE <sub>3</sub> ≥ V <sub>IH</sub> , CE <sub>2</sub> ≤ V <sub>IL</sub> , V <sub>IN</sub> ≥ V <sub>IH</sub> or V <sub>IN</sub> ≤ V <sub>IL</sub> , f = f <sub>MAX</sub>		30	mA
I <sub>SB2</sub>	Automatic CE power-down current — CMOS inputs	Max V <sub>CC</sub> , CE <sub>1</sub> , CE <sub>3</sub> ≥ V <sub>CC</sub> - 0.3 V, CE <sub>2</sub> ≤ 0.3 V, V <sub>IN</sub> ≥ V <sub>CC</sub> - 0.3 V, or V <sub>IN</sub> ≤ 0.3 V, f = 0		25	mA

## Capacitance

Tested initially and after any design or process changes that may affect these parameters.

Parameter	Description	Test Conditions	Max	Unit
C <sub>IN</sub>	Input capacitance	T <sub>A</sub> = 25 °C, f = 1 MHz, V <sub>CC</sub> = 3.3 V	8	pF
C <sub>OUT</sub>	IO capacitance		10	pF

## Thermal Resistance

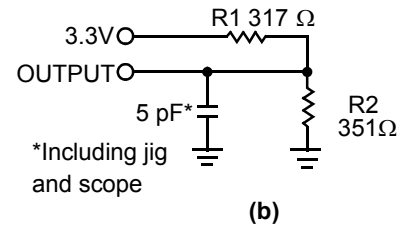
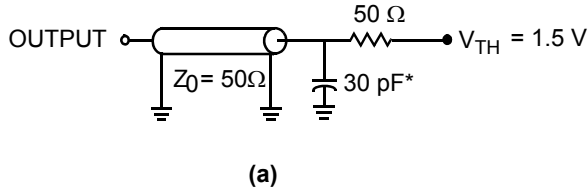
Tested initially and after any design or process changes that may affect these parameters.

Parameter	Description	Test Conditions	119-Ball PBGA	Unit
θ <sub>JA</sub>	Thermal resistance (junction to ambient)	Still air, soldered on a 3 × 4.5 inch, four layer printed circuit board	20.31	°C/W
θ <sub>JC</sub>	Thermal resistance (junction to case)		8.35	°C/W

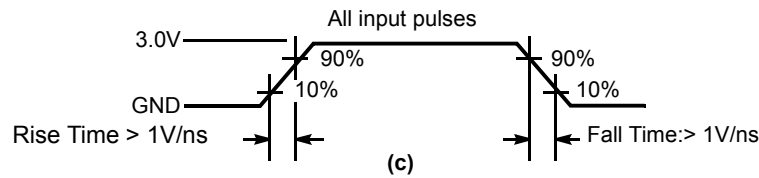
### Notes

- V<sub>IL</sub> (min) = -2.0 V and V<sub>IH</sub> (max) = V<sub>CC</sub> + 2 V for pulse durations of less than 20 ns.
- CE refers to a combination of CE<sub>1</sub>, CE<sub>2</sub>, and CE<sub>3</sub>. CE is active LOW when CE<sub>1</sub> is LOW, CE<sub>2</sub> is HIGH, and CE<sub>3</sub> is LOW. CE is HIGH when CE<sub>1</sub> is HIGH or CE<sub>2</sub> is LOW or CE<sub>3</sub> is HIGH.

### AC Test Loads and Waveform [4]



\*Capacitive Load consists of all components of the test environment



### AC Switching Characteristics

Over the operating range [5]

Parameter	Description	-10		Unit
		Min	Max	
<b>Read Cycle</b>				
$t_{power}^{[6]}$	$V_{CC}$ (Typical) to the first access	100	–	$\mu s$
$t_{RC}$	Read cycle time	10	–	ns
$t_{AA}$	Address to data valid	–	10	ns
$t_{OHA}$	Data hold from address change	3	–	ns
$t_{ACE}$	$\overline{CE}$ active LOW to data valid [3]	–	10	ns
$t_{DOE}$	$\overline{OE}$ LOW to data valid	–	5	ns
$t_{LZOE}$	$\overline{OE}$ LOW to low Z [7]	1	–	ns
$t_{HZOE}$	$\overline{OE}$ HIGH to high Z [7]	–	5	ns
$t_{LZCE}$	$\overline{CE}$ active LOW to low Z [3, 7]	3	–	ns
$t_{HZCE}$	$\overline{CE}$ deselect HIGH to high Z [3, 7]	–	5	ns
$t_{PU}$	$\overline{CE}$ active LOW to power-up [3, 8]	0	–	ns
$t_{PD}$	$\overline{CE}$ deselect HIGH to power-down [3, 8]	–	10	ns

**Notes**

- Valid SRAM operation does not occur until the power supplies reach the minimum operating  $V_{DD}$  (3.0 V). 100  $\mu s$  ( $t_{power}$ ) after reaching the minimum operating  $V_{DD}$ , normal SRAM operation begins including reduction in  $V_{DD}$  to the data retention ( $V_{CCDR}$ , 2.0 V) voltage.
- Test conditions assume signal transition time of 3 ns or less, timing reference levels of 1.5 V, and input pulse levels of 0 to 3.0V. Test conditions for the read cycle use output loading as shown in part a) of the AC Test Loads and Waveform [4], unless specified otherwise.
- $t_{POWER}$  gives the minimum amount of time that the power supply is at typical  $V_{CC}$  values until the first memory access is performed.
- $t_{HZOE}$ ,  $t_{HZCE}$ ,  $t_{HZWE}$ ,  $t_{LZOE}$ ,  $t_{LZCE}$ , and  $t_{LZWE}$  are specified with a load capacitance of 5 pF as in part (b) of AC Test Loads and Waveform [4]. Transition is measured  $\pm 200$  mV from steady state voltage.
- These parameters are guaranteed by design and are not tested.

**AC Switching Characteristics** (continued)

Over the operating range [5]

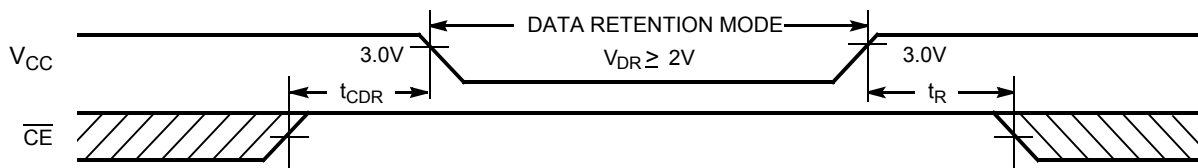
Parameter	Description	-10		Unit
		Min	Max	
<b>Write Cycle</b> [9, 10, 13]				
$t_{WC}$	Write cycle time	10	–	ns
$t_{SCE}$	$\overline{CE}$ active LOW to write end [3]	7	–	ns
$t_{AW}$	Address setup to write end	7	–	ns
$t_{HA}$	Address hold from write end	0	–	ns
$t_{SA}$	Address setup to write start	0	–	ns
$t_{PWE}$	$\overline{WE}$ pulse width	7	–	ns
$t_{SD}$	Data setup to write end	5.5	–	ns
$t_{HD}$	Data hold from write end	0	–	ns
$t_{LZWE}$	$\overline{WE}$ HIGH to low Z [7]	3	–	ns
$t_{HZWE}$	$\overline{WE}$ LOW to high Z [7]	–	5	ns

**Data Retention Characteristics**

Over the operating range

Parameter	Description	Conditions [3]	Min	Typ	Max	Unit
$V_{DR}$	$V_{CC}$ for data retention		2	–	–	V
$I_{CCDR}$	Data retention current [9]	$V_{CC} = 2V, CE_1, CE_3 \geq V_{CC} - 0.2V, CE_2 \leq 0.2V, V_{IN} \geq V_{CC} - 0.2V$ or $V_{IN} \leq 0.2V$	–	–	25	mA
$t_{CDR}$ [11]	Chip deselect to data retention time		0	–	–	ns
$t_R$ [12]	Operation recovery time		$t_{RC}$	–	–	ns

Figure 2. Data Retention Waveform



**Notes**

9. The internal write time of the memory is defined by the overlap of  $\overline{CE}_1$  LOW,  $CE_2$  HIGH,  $\overline{CE}_3$  LOW, and  $\overline{WE}$  LOW. Chip enables must be active and  $\overline{WE}$  must be LOW to initiate a write and the transition of any of these signals terminates the write. The input data setup and hold timing are referenced to the leading edge of the signal that terminates the write.
10. The minimum write cycle time for Write Cycle No. 3 ( $\overline{WE}$  controlled,  $\overline{OE}$  LOW) is the sum of  $t_{HZWE}$  and  $t_{SD}$ .
11. Tested initially and after any design or process changes that may affect these parameters.
12. Full device operation requires linear  $V_{CC}$  ramp from  $V_{DR}$  to  $V_{CC(min)} \geq 50 \mu s$  or stable at  $V_{CC(min)} \geq 50 \mu s$ .

### Switching Waveforms

Figure 3. Read Cycle No. 1 (Address Transition Controlled) [13, 14]

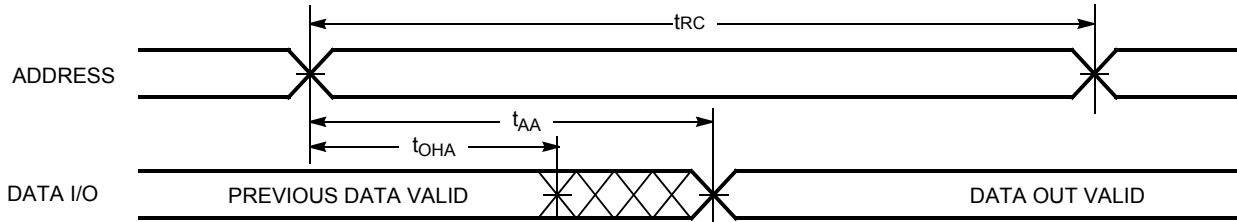


Figure 4. Read Cycle No. 2 ( $\overline{OE}$  Controlled) [3, 14, 15]

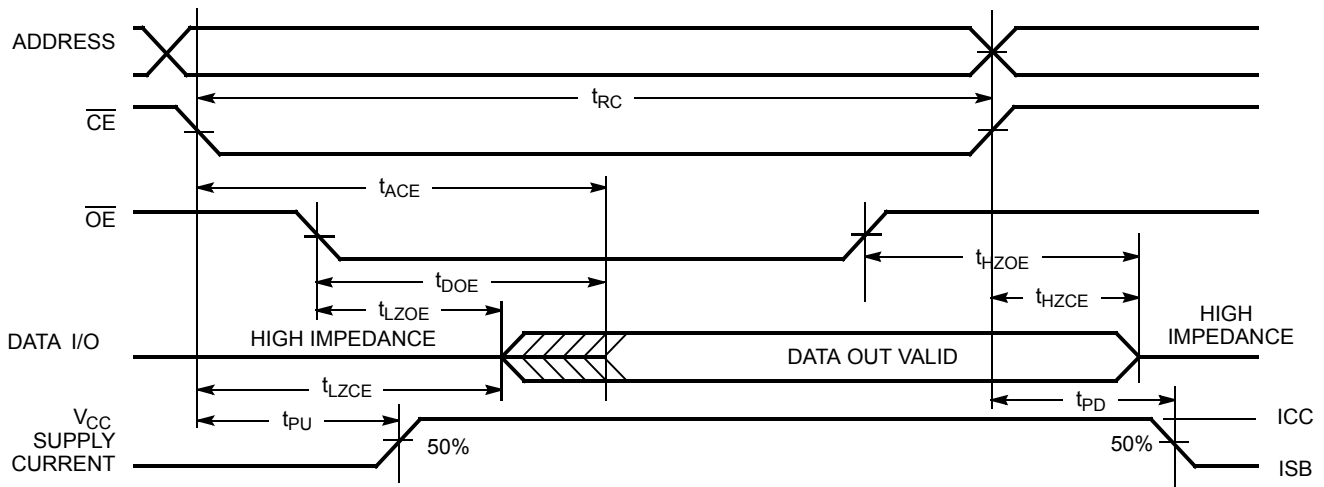
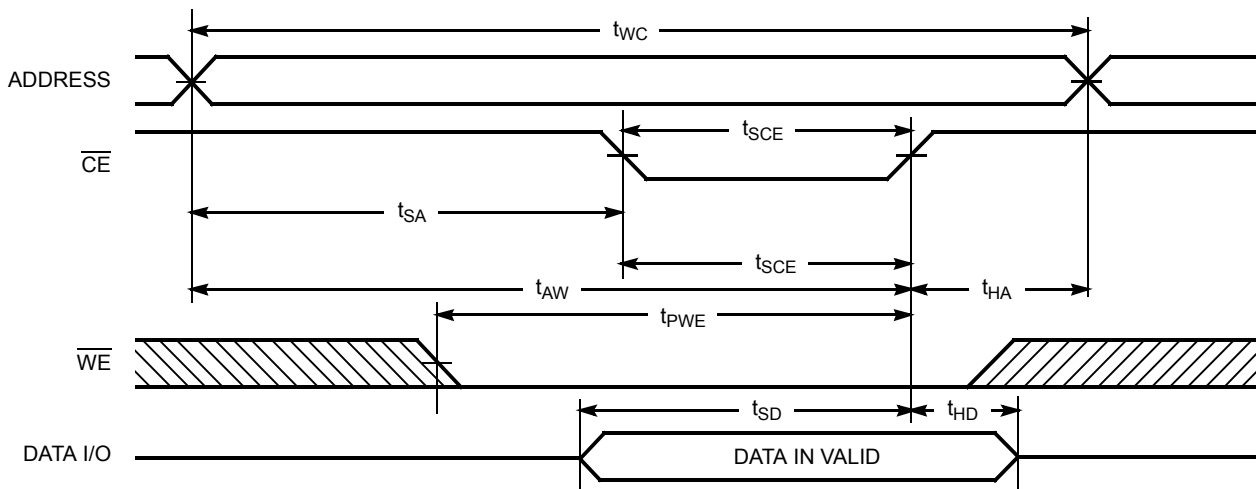


Figure 5. Write Cycle No. 1 ( $\overline{CE}$  Controlled) [3, 16, 17]



**Notes**

- 13. Device is continuously selected.  $\overline{OE}$ ,  $\overline{CE} = V_{IL}$ .
- 14. WE is HIGH for read cycle.
- 15. Address valid before or similar to  $\overline{CE}$  transition LOW.
- 16. Data IO is high impedance if  $\overline{OE} = V_{IH}$ .
- 17. If CE goes HIGH simultaneously with WE going HIGH, the output remains in a high impedance state.

Switching Waveforms (continued)

Figure 6. Write Cycle No. 2 ( $\overline{WE}$  Controlled,  $\overline{OE}$  HIGH During Write) [3, 16, 17]

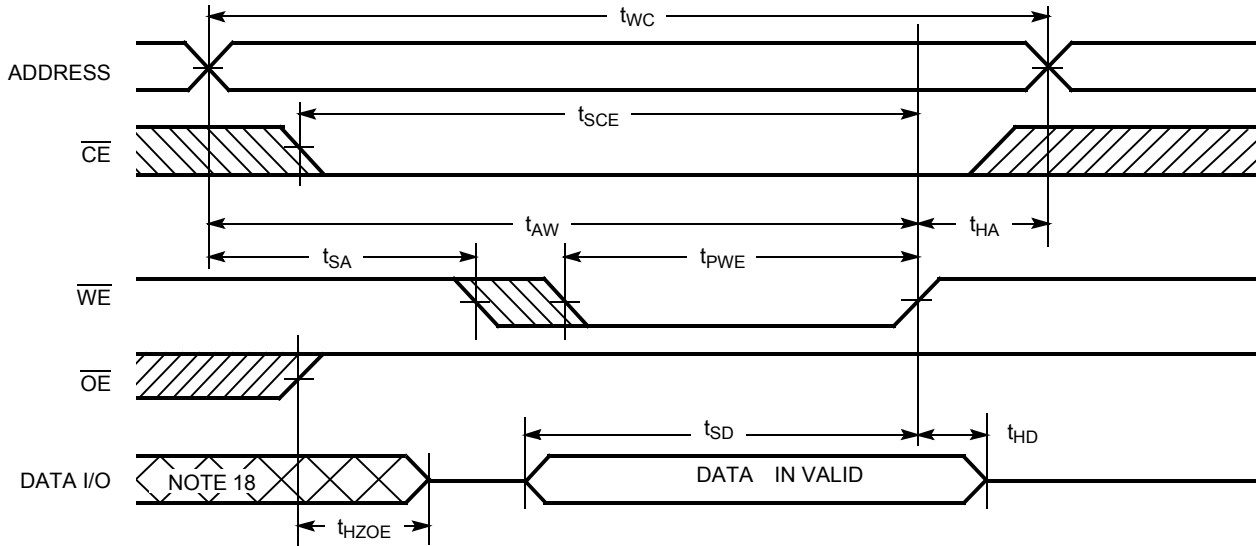
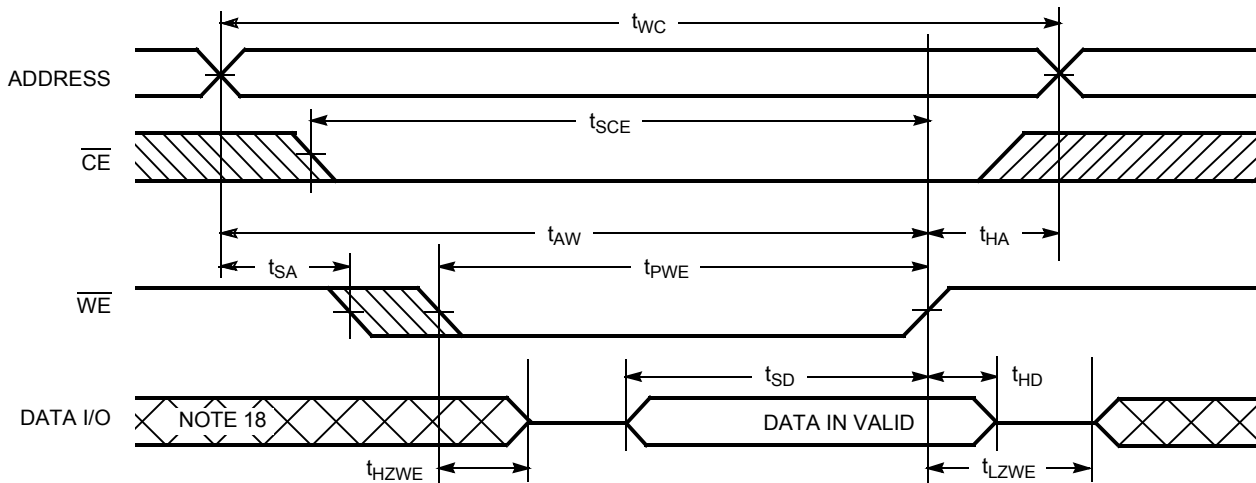


Figure 7. Write Cycle No. 3 ( $\overline{WE}$  Controlled,  $\overline{OE}$  LOW) [3, 17, 19]



Truth Table

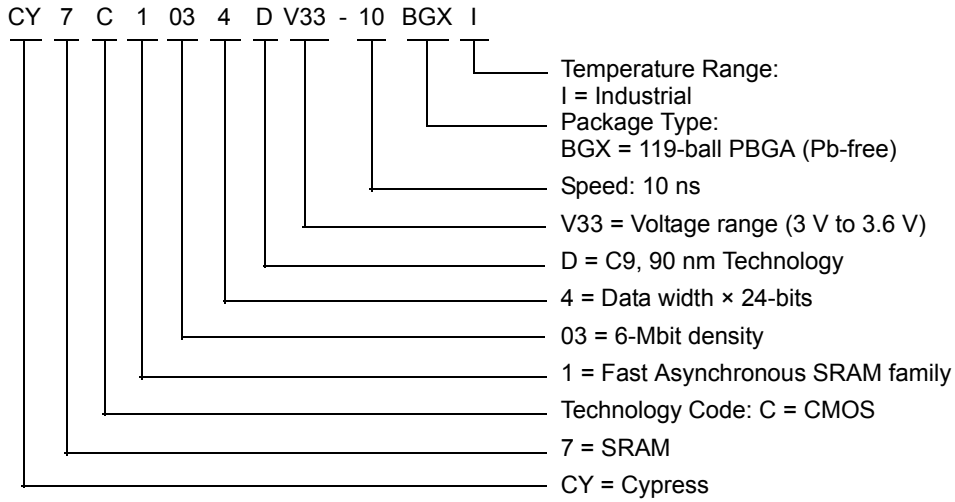
$\overline{CE}_1$	$\overline{CE}_2$	$\overline{CE}_3$	$\overline{OE}$	$\overline{WE}$	$IO_0 - IO_{23}$	Mode	Power
H	X	X	X	X	High Z	Power-down	Standby ( $I_{SB}$ )
X	L	X	X	X	High Z	Power-down	Standby ( $I_{SB}$ )
X	X	H	X	X	High Z	Power-down	Standby ( $I_{SB}$ )
L	H	L	L	H	Full Data Out	Read	Active ( $I_{CC}$ )
L	H	L	X	L	Full Data In	Write	Active ( $I_{CC}$ )
L	H	L	H	H	High Z	Selected, outputs disabled	Active ( $I_{CC}$ )

NOTE  
 18. During this period, the IOs are in the output state and input signals are not applied.  
 19. The minimum write cycle pulse width should be equal to the sum of  $t_{SD}$  and  $t_{HZWE}$ .

**Ordering Information**

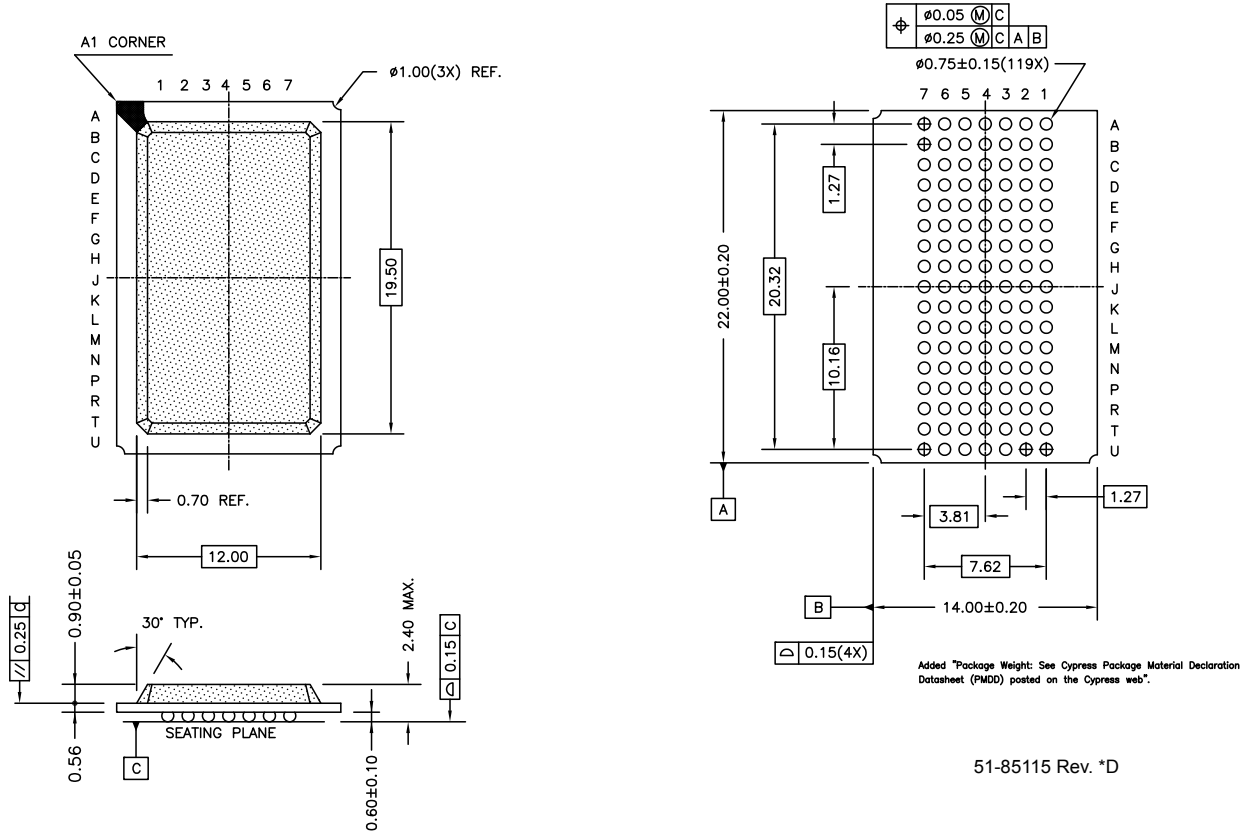
Speed (ns)	Ordering Code	Package Name	Package Type	Operating Range
10	CY7C1034DV33-10BGXI	51-85115	119-ball Plastic Ball Grid Array (14 x 22 x 2.4 mm) (Pb-free)	Industrial

**Ordering Code Definitions**



Package Diagram

Figure 8. 119-ball PBGA (14 x 22 x 2.4 mm)



51-85115 Rev. \*D

## Acronyms

Acronym	Description
CMOS	complementary metal oxide semiconductor
I/O	input/output
SRAM	static random access memory
TSOP	thin small outline package
TTL	transistor-transistor logic

## Document Conventions

### Units of Measure

Symbol	Unit of Measure
°C	degrees Celsius
μA	microamperes
mA	milliamperes
MHz	megahertz
ns	nanoseconds
pF	picofarads
V	volts
Ω	ohms
W	watts

Document History Page

Document Title: CY7C1034DV33 6-Mbit (256K X 24) Static RAM				
Document Number: 001-08351				
REV.	ECN NO.	Orig. of Change	Submission Date	Description of Change
**	469517	NXR	See ECN	New data sheet
*A	499604	NXR	See ECN	Added note 1 for NC pins Changed I <sub>CC</sub> specification from 150 mA to 185 mA Updated Test Condition for I <sub>CC</sub> in DC Electrical Characteristics table Added note for t <sub>ACE</sub> , t <sub>LZCE</sub> , t <sub>HZCE</sub> , t <sub>PU</sub> , t <sub>PD</sub> , t <sub>SCE</sub> in AC Switching Characteristics Table on page 4
*B	1462586	VKN/SFV	See ECN	Converted from preliminary to final Updated block diagram Changed I <sub>CC</sub> specification from 185 mA to 225 mA Updated thermal specs
*C	2644842	VKN/PYRS	01/23/09	Replaced Commercial range with the Industrial Replaced 8 ns speed with 10 ns
*D	3109199	PRAS	12/13/2010	Added <a href="#">Ordering Code Definitions</a> . Updated <a href="#">Package Diagram</a> .
*E	3388455	TAVA	09/29/2011	Minor text edits. Added <a href="#">Acronyms</a> and <a href="#">Document Conventions</a> . Updated template.
*F	4548836	MEMJ	10/22/2014	Updated <a href="#">Package Diagram</a> : spec 51-85115 – Changed revision from *C to *D Completing Sunset Review.
*G	4576478	MEMJ	11/21/2014	Added related documentation hyperlink in page 1. Added Note 19 in <a href="#">Switching Waveforms</a> . Added note reference 19 in <a href="#">Figure 7</a> .

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Touch Sensing	<a href="http://cypress.com/go/touch">cypress.com/go/touch</a>
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